

MOSFET – N-Channel, POWERTRENCH®

30 V, 19.5 A, 5.3 mΩ

FDMC7678

General Description

This N-Channel MOSFET is produced using onsemi's advanced POWERTRENCH® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

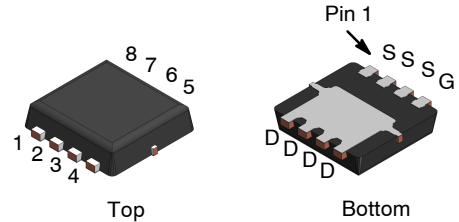
Features

- Max $r_{DS(on)}$ = 5.3 mΩ at $V_{GS} = 10\text{ V}$, $I_D = 17.5\text{ A}$
- Max $r_{DS(on)}$ = 6.8 mΩ at $V_{GS} = 4.5\text{ V}$, $I_D = 15.0\text{ A}$
- High Performance Technology for Extremely Low $r_{DS(on)}$
- This Device is Pb-Free, Halide Free and is RoHS Compliant

Applications

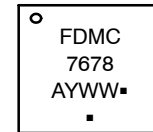
- DC – DC Buck Converters
- Notebook Battery Power Management
- Load Switch in Notebook

V_{DSS}	$R_{DS(on)}$ MAX	I_D MAX
30 V	5.3 mΩ @ 10 V	19.5 A
	6.8 mΩ @ 4.5 V	



WDFN8 3.3x3.3, 0.65P
CASE 511DR

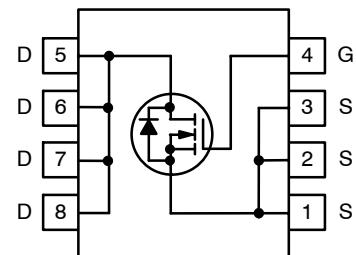
MARKING DIAGRAM



FDMC7678 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

FDMC7678

MOSFET MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

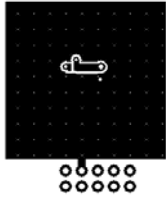
Symbol	Parameter		Ratings	Unit	
V_{DS}	Drain to Source Voltage		30	V	
V_{GS}	Gate to Source Voltage (Note 3)		± 20	V	
I_D	Drain Current	Continuous (Package Limited)	$T_C = 25^\circ\text{C}$	19.5	A
		Continuous (Silicon Limited)	$T_C = 25^\circ\text{C}$	63	
		Continuous (Note 1a)	$T_A = 25^\circ\text{C}$	17.5	
		Pulsed		70	A
E_{AS}	Single Pulse Avalanche Energy (Note 4)		54	mJ	
P_D	Power Dissipation		$T_C = 25^\circ\text{C}$	31	W
	Power Dissipation (Note 1a)		$T_A = 25^\circ\text{C}$	2.3	
T_J, T_{STG}	Operating and Storage Junction Temperature Range		-55 to + 150	$^\circ\text{C}$	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	4.0	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

- $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. $53^\circ\text{C}/\text{W}$ when mounted on a 1 in² pad of 2 oz copper



b. $125^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper

FDMC7678

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30	–	–	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	–	21	–	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V	–	–	1	μA
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V	–	–	100	nA

ON CHARACTERISTICS

V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	1.2	1.5	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	–	–5	–	mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 17.5 A	–	4.2	5.3	mΩ
		V _{GS} = 4.5 V, I _D = 15.0 A	–	5.1	6.8	
		V _{GS} = 10 V, I _D = 17.5A, T _J = 125°C	–	5.7	7.2	
g _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 17.5 A	–	90	–	S

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	–	1810	2410	pF
C _{oss}	Output Capacitance		–	620	820	pF
C _{rss}	Reverse Transfer Capacitance		–	75	110	pF
R _g	Gate Resistance		–	0.7	2.5	Ω

SWITCHING CHARACTERISTICS

t _{d(on)}	Turn-On Delay Time	V _{DD} = 15 V, I _D = 17.5 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	–	10	19	ns
t _r	Rise Time		–	4	10	ns
t _{d(off)}	Turn-Off Delay Time		–	26	41	ns
t _f	Fall Time		–	3	10	ns
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V, V _{DD} = 15 V, I _D = 17.5 A	–	28	39	nC
	Total Gate Charge	V _{GS} = 0 V to 4.5 V, V _{DD} = 15 V, I _D = 17.5 A	–	14	19	nC
Q _{gs}	Gate to Source Charge	V _{DD} = 15 V, I _D = 17.5 A	–	4.4	–	nC
Q _{gd}	Gate to Drain "Miller" Charge		–	3.9	–	nC

DRAIN-SOURCE DIODE CHARACTERISTICS

V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.9 A (Note 2)	–	0.7	1.2	V
		V _{GS} = 0 V, I _S = 17.5 A (Note 2)	–	0.8	1.2	
t _{rr}	Reverse Recovery Time	I _F = 17.5 A, di/dt = 100 A/μs	–	30	49	ns
Q _{rr}	Reverse Recovery Charge		–	13	23	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

3. As an N-ch device, the negative V_{GS} rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

4. E_{AS} of 54 mJ is based on starting T_J = 25°C, L = 0.3 mH, I_{AS} = 19 A, V_{DD} = 27 V, V_{GS} = 10 V.

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

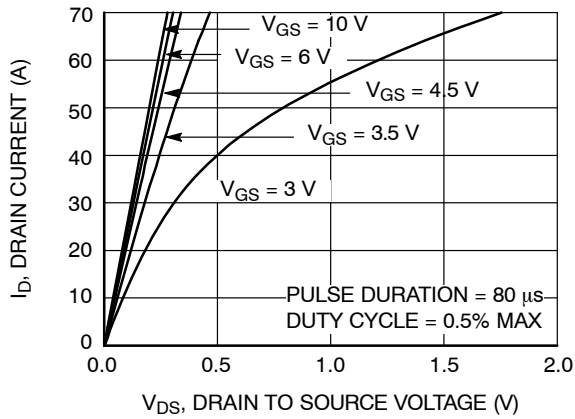


Figure 1. On Region Characteristics

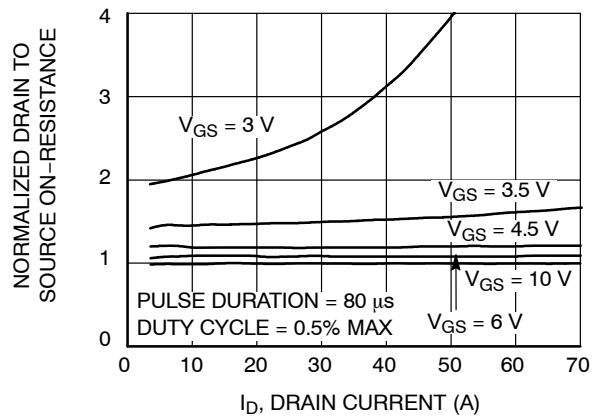


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

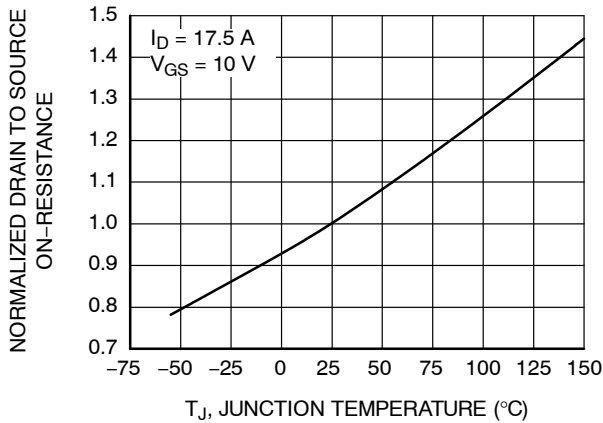


Figure 3. Normalized On Resistance vs. Junction Temperature

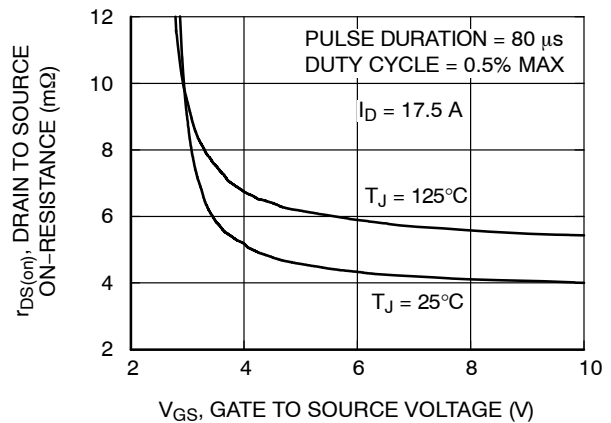


Figure 4. On-Resistance vs. Gate to Source Voltage

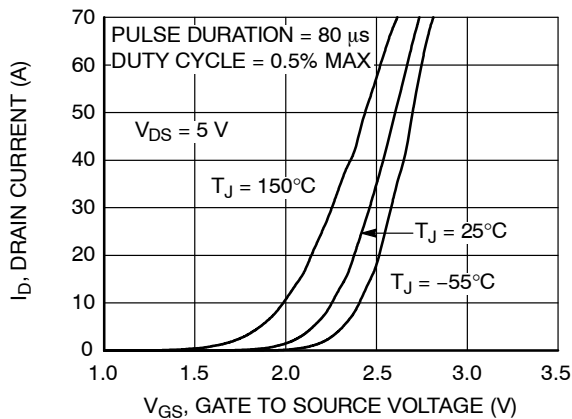


Figure 5. Transfer Characteristics

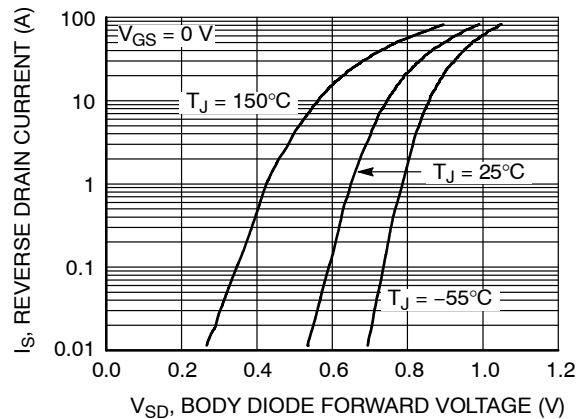


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED) (CONTINUED)

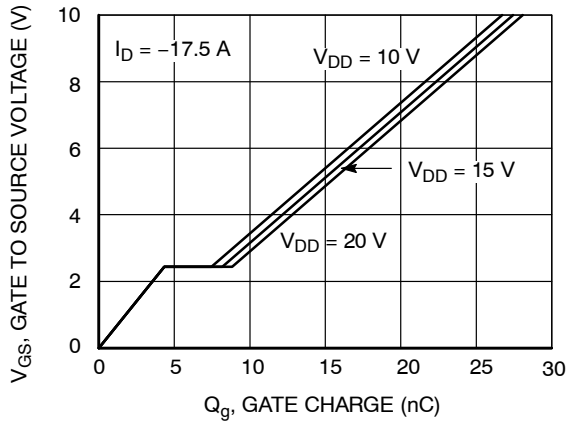


Figure 7. Gate Charge Characteristics

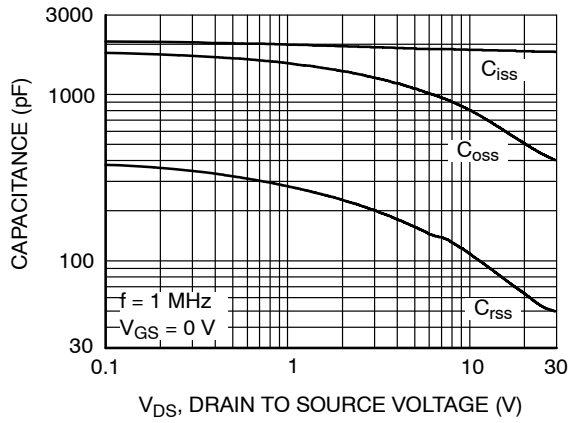


Figure 8. Capacitance vs. Drain to Source Voltage

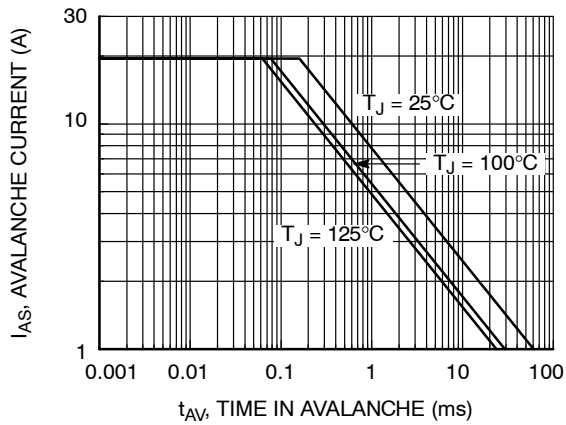


Figure 9. Unclamped Inductive Switching Capability

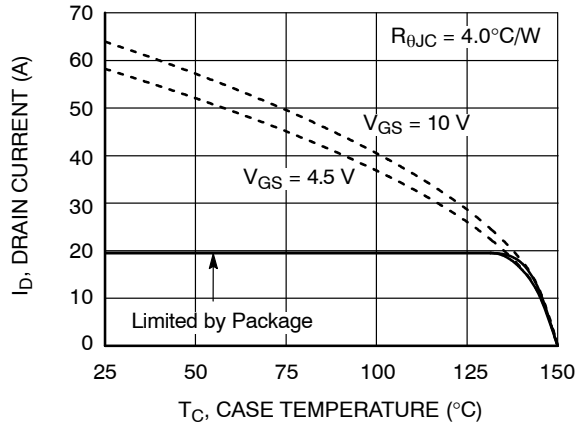


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

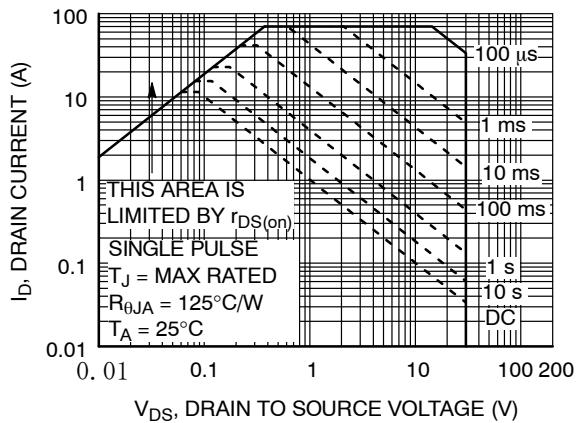


Figure 11. Forward Bias Safe Operating Area

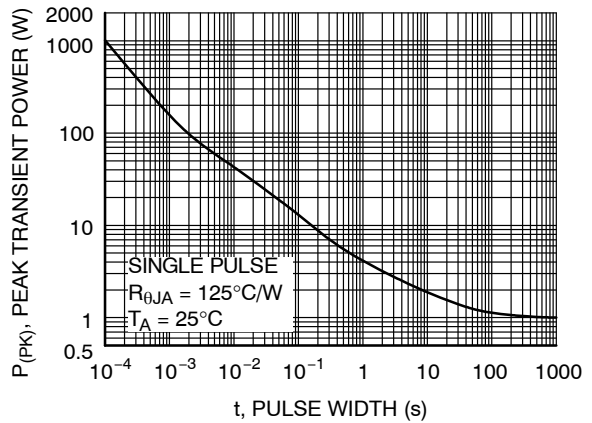


Figure 12. Single Pulse Maximum Power Dissipation

FDMC7678

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED) (CONTINUED)

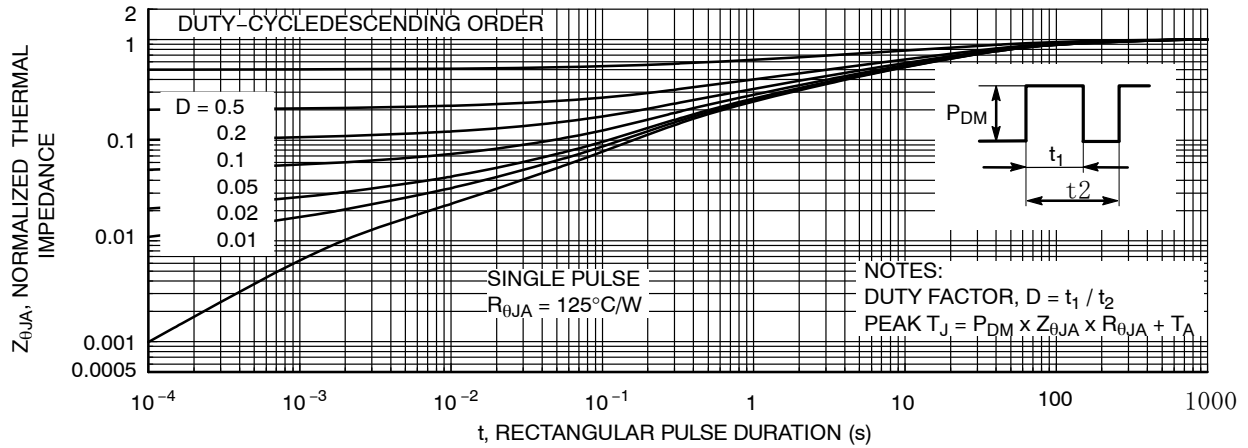
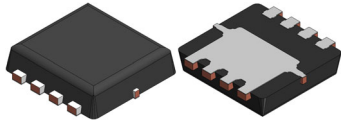


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

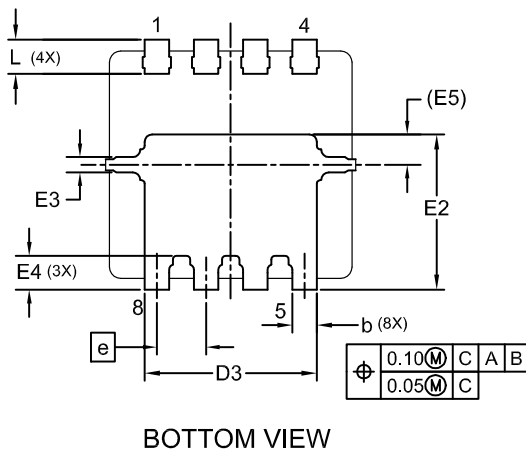
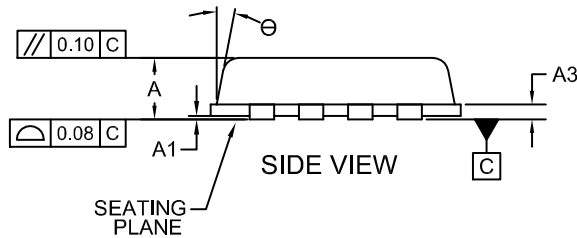
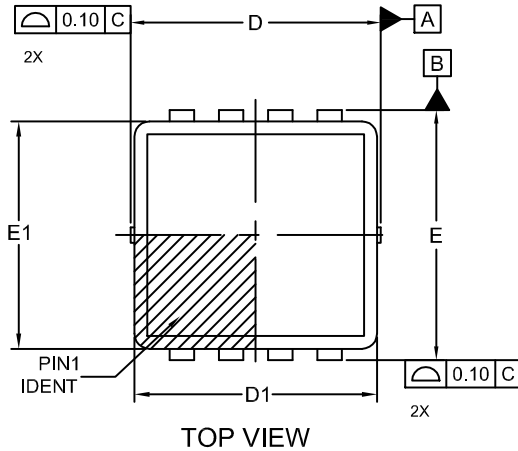
Device	Device Marking	Package	Reel Size	Tape Width	Shipping†
FDMC7678	FDMC7678	WDFN8 3.3x3.3, 0.65P (Pb-Free and Halide Free)	13"	12 mm	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).



WDFN8 3.3x3.3, 0.65P
CASE 511DR
ISSUE B

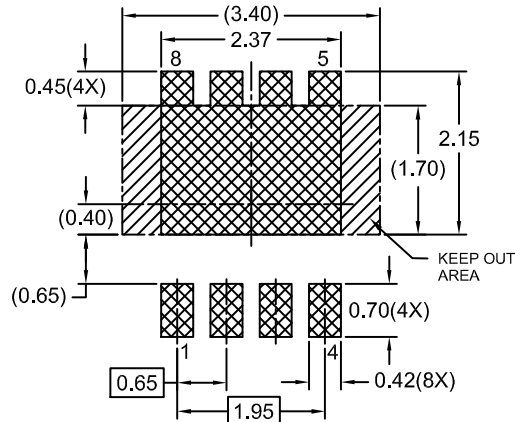
DATE 02 FEB 2022



NOTES:

- A. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- B. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- C. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS. MOLD FLASH PROTRUSION OR GATE BURR DOES NOT EXCEED 0.150MM.

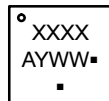
DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	-	0.05
A3	0.15	0.20	0.25
b	0.27	0.32	0.37
D	3.20	3.30	3.40
D1	3.10	3.20	3.30
D3	2.17	2.27	2.37
E	3.20	3.30	3.40
E1	2.90	3.00	3.10
E2	1.95	2.05	2.15
E3	0.15	0.20	0.25
E4	0.30	0.40	0.50
E5	0.40 REF		
e	0.65 BSC		
L	0.30	0.40	0.50
Θ	0°	-	12°



RECOMMENDED LAND PATTERN

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



- XXXX = Specific Device Code
- A = Assembly Location
- Y = Year
- WW = Work Week
- = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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